

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/528,312 FRANKE ET AL.	
		Examiner	Art Unit TESHOME HAILU	2139 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0120611	06-2003	Yoshino et al.	705/67
*	B	US-2003/0033528	02-2003	Ozog et al.	713/170
*	C	US-2002/0129241	09-2002	Doyle et al.	713/157
*	D	US-2002/0108042	08-2002	Oka et al.	713/175
*	E	US-7,243,236	07-2007	Sibert, W. Olin	713/179
*	F	US-6,948,061	09-2005	Dierks, Timothy	713/159
*	G	US-2002/0108041	08-2002	Watanabe et al.	713/175
H	US-				
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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